Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/695,227	HATTON ET AL.
Examiner	Art Unit

3754

PHILIPPE S. DERAKSHANI

	SEARCHED					
Class	Subclass	Date	Examiner			
222	494 207	10/3/2006	PD			
·						
·						

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
	:			